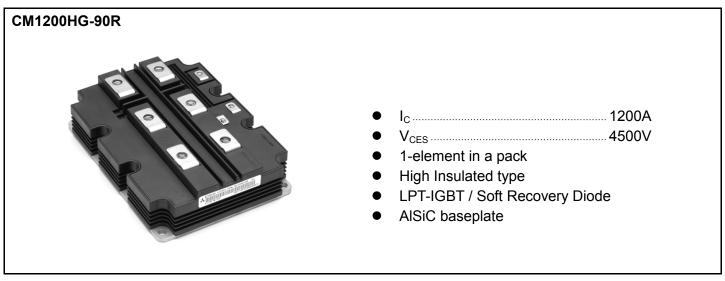


< HVIGBT MODULES >

CM1200HG-90R

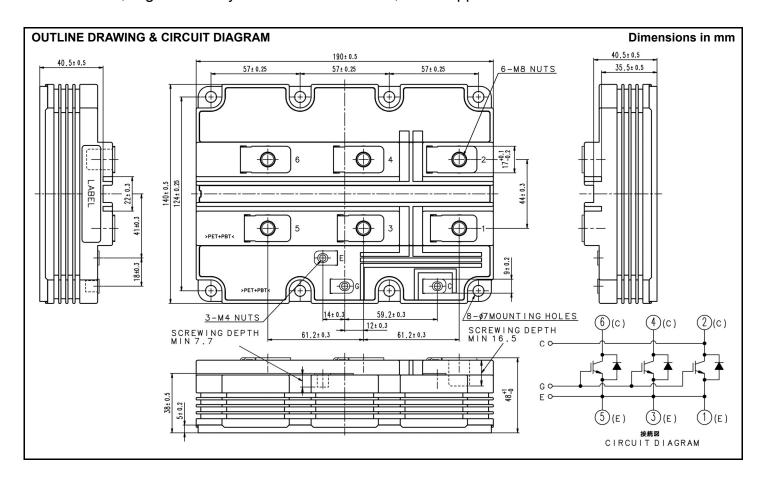
HIGH POWER SWITCHING USE INSULATED TYPE

4th-Version HVIGBT (High Voltage Insulated Gate Bipolar Transistor) Modules



APPLICATION

Traction drives, High Reliability Converters / Inverters, DC choppers



4th-Version HVIGBT (High Voltage Insulated Gate Bipolar Transistor) Modules

MAXIMUM RATINGS

Symbol	Item	Conditions	Ratings	Unit
V	Collector-emitter voltage	$V_{GE} = 0V, T_j = -40+125^{\circ}C$	4500	V
V _{CES}		$V_{GE} = 0V, T_j = -50^{\circ}C$	4400	V
V _{GES} Gate-emitter voltage		$V_{CE} = 0V, T_j = 25^{\circ}C$	± 20	V
Ic	Collector current	DC, $T_c = 85^{\circ}C$	1200	Α
I _{CRM}	Collector current	Pulse (Note 1)	2400	Α
I _E	Emitter current	DC	1200	Α
I _{ERM}	Emitter current (Note 2)	Pulse (Note 1)	2400	Α
P _{tot}	Maximum power dissipation (Note 3)	T _c = 25°C, IGBT part	11900	W
V _{iso}	Isolation voltage	RMS, sinusoidal, f = 60Hz, t = 1 min.	10200	V
V _e	Partial discharge extinction voltage	RMS, sinusoidal, f = 60Hz, Q _{PD} ≤ 10 pC	5100	V
Tj	Junction temperature		− 50 ~ +150	°C
T _{jop}	Operating junction temperature		− 50 ~ +125	°C
T_{stg}	Storage temperature		− 55 ~ + 125	°C
t _{psc}	Short circuit pulse width	V_{CC} = 3200V, $V_{CE} \le V_{CES}$, V_{GE} =15V, T_j =125°C	10	μS

ELECTRICAL CHARACTERISTICS

Symbol Item		Conditions		Limits			Unit
				Min	Тур	Max	Offic
	Collector cutoff current	$V_{CE} = V_{CES}, V_{GE} = 0V$	T _j = 25°C	_	_	16.0	mA
I _{CES}	Collector cutoff current	V _{CE} = V _{CES} , V _{GE} = UV	T _j = 125°C	_	16.0	_	IIIA
$V_{GE(th)}$	Gate-emitter threshold voltage	$V_{CE} = 10 \text{ V}, I_{C} = 120 \text{ mA}, T_{j} = 25^{\circ}\text{C}$		5.8	6.3	6.8	V
I _{GES}	Gate leakage current	$V_{GE} = V_{GES}, V_{CE} = 0V, T_j = 25^{\circ}C$		-0.5	_	0.5	μΑ
C _{ies}	Input capacitance	\\ -40\\\\ -0\\f-400\\		_	175.0	_	nF
C _{oes}	Output capacitance	$V_{CE} = 10 \text{ V}, V_{GE} = 0 \text{ V}, f = 100 \text{ kHz}$ $T_i = 25^{\circ}\text{C}$		_	11.0	_	nF
Cres	Reverse transfer capacitance	1 _j = 25 C		_	5.0	_	nF
Q _G	Total gate charge	V_{CC} = 2800V, I_{C} = 1200A, V_{GE} = ±15V		_	13.5	_	μC
	Collector conittor activistics well-	I _C = 1200 A (Note 4)	T _j = 25°C	_	3.50	_	V
V _{CEsat}	Collector-emitter saturation voltage	V _{GE} = 15 V	T _j = 125°C	_	4.40	5.10	V
_	Turn or deleviting	V _{CC} = 2800 V	T _j = 25°C	_	1.00	_	
$t_{d(on)}$	Turn-on delay time		T _i = 125°C	_	0.95	1.50	μs
_	Town on the time	I _C = 1200 A	T _j = 25°C	_	0.28	_	
t _r	Turn-on rise time	V _{GE} = ±15 V	T _j = 125°C	_	0.30	0.50	μs
_	Turn an auditability (Note 5)	$R_{G(on)} = 2.7 \Omega$	T _j = 25°C	_	4.30	_	
E _{on(10%)}	Turn-on switching energy (NOLE 5)	L _s = 150 nH	T _j = 125°C	_	5.10	_	J
_	Turn an auditabilina an annu (Note 6)	Inductive load	T _i = 25°C	_	4.60	_	
E _{on}	Turn-on switching energy (NOTE 6)		T _i = 125°C	_	5.50	_	J
	T (6.1.1.1)		T _i = 25°C	_	3.60	_	
$t_{d(off)}$	Turn-off delay time	V _{CC} = 2800 V	T _i = 125°C	_	3.80	5.00	μs
		I _C = 1200 A	T _i = 25°C	_	0.35	_	
t _f	Turn-off fall time	V _{GE} = ±15 V	T _i = 125°C	_	0.45	1.00	μs
_	Turn off awitabing aparay (Note 5)	$R_{G(off)} = 10 \Omega$	T _i = 25°C	_	2.90		
E _{off(10%)}	Turn-off switching energy (Note 5)	L _s = 150 nH	T _i = 125°C	_	3.85	_	J
_	Turn off quitable a page (Note 6)	Inductive load	T _j = 25°C	_	3.20	_	
E _{off}	Turn-off switching energy (Note 6)		T _j = 125°C	_	4.30	_	J

< HVIGBT MODULES >

CM1200HG-90R

HIGH POWER SWITCHING USE INSULATED TYPE

4th-Version HVIGBT (High Voltage Insulated Gate Bipolar Transistor) Modules

ELECTRICAL CHARACTERISTICS (continuation)

Symbol	Item		Conditions		Limits			Unit
Syllibol					Min	Тур	Max	Offic
V	Emitter collector voltage	(Note 2)	I _E = 1200 A ^(Note 4)	T _j = 25°C	1	2.50	_	>
V _{EC}	Emitter-collector voltage (Note 2)		$V_{GE} = 0 V$	T _j = 125°C	_	2.80	3.40	٧
+	Reverse recovery time (Note 2)	(Note 2)		T _j = 25°C	_	0.70	_	
t _{rr}			T _j = 125°C		0.90	_	μs	
	Reverse recovery current (Note 2)	(Note 2)	V _{CC} = 2800 V	T _j = 25°C	1	1100	_	Α
Irr			I _C = 1200 A	T _j = 125°C	1	1200	_	Α.
	Reverse recovery charge (Note 2)	(Note 2)	$V_{GE} = \pm 15 \text{ V}$	$T_j = 25^{\circ}C$	_	1000	_	μC
Q _{rr}		$R_{G(on)} = 2.7 \Omega$	T _j = 125°C	1	1500	_	μΟ	
_	Reverse recovery energy (Note 2) (Note 5)	(Note 2)	$L_s = 150 \text{ nH}$	T _j = 25°C	1	1.30	_	
E _{rec(10%)}		Inductive load	T _j = 125°C	_	2.10	_	J	
Г	Reverse recovery energy	(Note 2)		T _j = 25°C	_	1.55	_	
E _{rec}		(Note 6)		T _j = 125°C	_	2.40	_	J

THERMAL CHARACTERISTICS

Symbol	Item	Conditions		Limits		
Syllibol				Тур	Max	Unit
$R_{th(j-c)Q}$	Thermal resistance	Junction to Case, IGBT part	l		10.5	K/kW
R _{th(j-c)D}	Thermal resistance	Junction to Case, FWDi part			19.5	K/kW
R _{th(c-s)}	Contact thermal resistance	Case to heat sink, $\lambda_{grease} = 1W/m^*k$, $D_{(c-s)} = 100\mu m$	_	6.0	_	K/kW

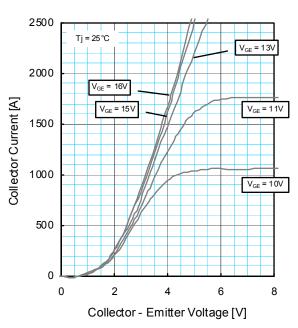
MECHANICAL CHARACTERISTICS

Symbol	Item	Conditions -	Limits			Unit
Syllibol			Min	Тур	Max	Offic
M _t		M8 : Main terminals screw	7.0	I	22.0	N·m
Ms	Mounting torque	M6 : Mounting screw	3.0	I	6.0	N·m
M_t		M4 : Auxiliary terminals screw	1.0	I	3.0	N·m
m	Mass		_	1.4		kg
CTI	Comparative tracking index		600		_	_
d _a	Clearance		26.0	1	1	mm
d _s	Creepage distance		56.0			mm
L _{P CE}	Parasitic stray inductance		_	15.0	_	nΗ
R _{CC'+EE'}	Internal lead resistance	T _C = 25°C		0.18	1	mΩ
r _g	Internal gate resistance	T _C = 25°C	_	1.7	1	Ω

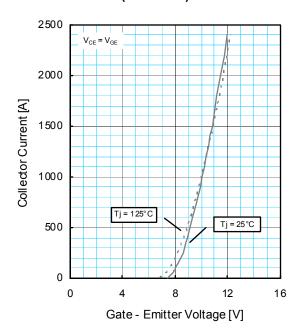
Note1. Pulse width and repetition rate should be such that junction temperature (T_i) does not exceed T_{jopmax} rating.

- $2. \ \ The \ symbols \ represent \ characteristics \ of the \ anti-parallel, \ emitter \ to \ collector \ free-wheel \ diode \ (FWD_i).$
- 3. Junction temperature (T_j) should not exceed T_{jmax} rating (150°C).
- 4. Pulse width and repetition rate should be such as to cause negligible temperature rise.
- 5. $E_{on(10\%)}$ / $E_{off(10\%)}$ / $E_{rec(10\%)}$ are the integral of 0.1 V_{CE} x 0.1 I_{C} x dt.
- 6. Definition of all items is according to IEC 60747, unless otherwise specified.

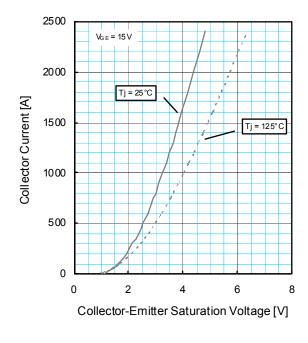
OUTPUT CHARACTERISTICS (TYPICAL)



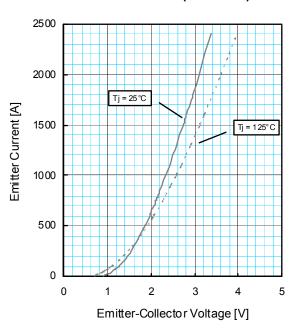
TRANSFER CHARACTERISTICS (TYPICAL)



COLLECTOR-EMITTER SATURATION VOLTAGE CHARACTERISTICS (TYPICAL)

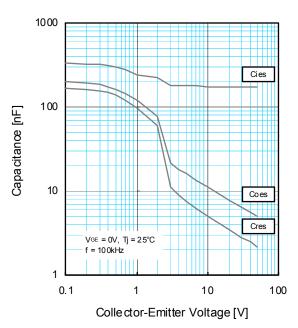


FREE-WHEEL DIODE FORWARD CHARACTERISTICS (TYPICAL)

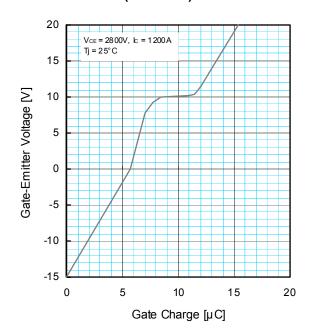


INSULATED TYPE

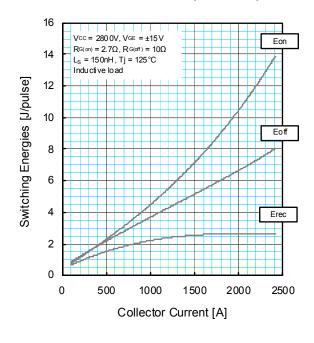
CAPACITANCE CHARACTERISTICS (TYPICAL)



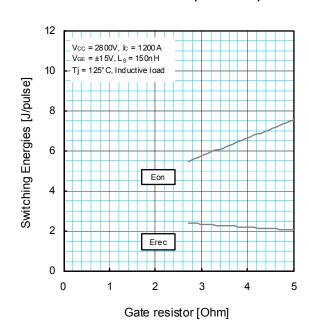
GATE CHARGE CHARACTERISTICS (TYPICAL)



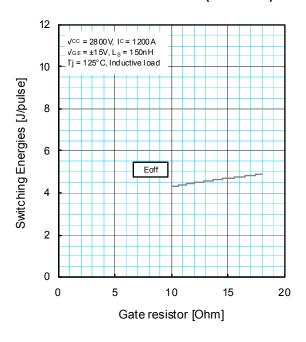
HALF-BRIDGE SWITCHING ENERGY CHARACTERISTICS (TYPICAL)



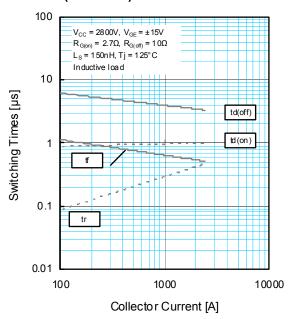
HALF-BRIDGE SWITCHING ENERGY CHARACTERISTICS (TYPICAL)



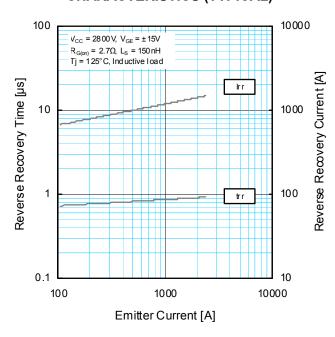
SWITCHING ENERGY CHARACTERISTICS (TYPICAL)



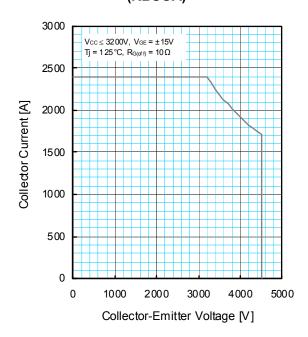
HALF-BRIDGE SWITCHING TIME CHARACTERISTICS (TYPICAL)HALF-BRIDGE



FREE-WHEEL DIODE REVERSE RECOVERY CHARACTERISTICS (TYPICAL)

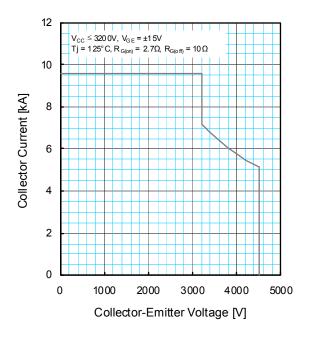


REVERSE BIAS SAFE OPERATING AREA (RBSOA)

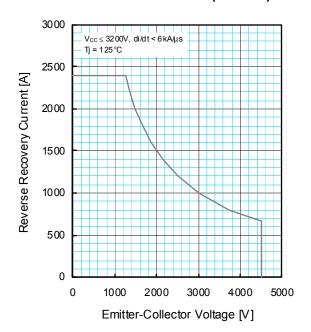


INSULATED TYPE

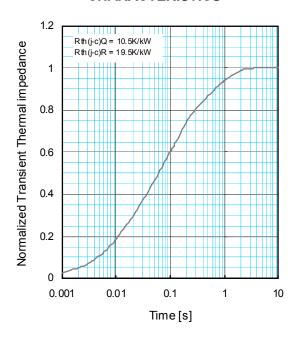
SHORT CIRCUIT SAFE OPERATING AREA (SCSOA)



FREE-WHEEL DIODE REVERSE RECOVERY SAFE OPERATING AREA (RRSOA)



TRANSIENT THERMAL IMPEDANCE CHARACTERISTICS



$$Z_{th(j-c)}(t) = \sum_{i=1}^{n} R_{i} \left\{ 1 - exp^{\left(-\frac{t}{\tau_{i}}\right)} \right\}$$

	1	2	3	4
R_i [K/kW]:	0.0055	0.2360	0.4680	0.2905
t _i [sec]:	0.0001	0.0131	0.0878	0.6247

Keep safety first in your circuit designs!

Mitsubishi Electric Corporation puts the maximum effort into making semiconductor products better and more reliable, but there is always the possibility that trouble may occur with them. Trouble with semiconductors may lead to personal injury, fire or property damage. Remember to give due consideration to safety when making your circuit designs, with appropriate measures such as (i) placement of substitutive, auxiliary circuits, (ii) use of non-flammable material or (iii) prevention against any malfunction or mishap.

Notes regarding these materials

- •These materials are intended as a reference to assist our customers in the selection of the Mitsubishi semiconductor product best suited to the customer's application; they do not convey any license under any intellectual property rights, or any other rights, belonging to Mitsubishi Electric Corporation or a third party.
- •Mitsubishi Electric Corporation assumes no responsibility for any damage, or infringement of any third-party's rights, originating in the use of any product data, diagrams, charts, programs, algorithms, or circuit application examples contained in these materials.
- •All information contained in these materials, including product data, diagrams, charts, programs and algorithms represents information on products at the time of publication of these materials, and are subject to change by Mitsubishi Electric Corporation without notice due to product improvements or other reasons. It is therefore recommended that customers contact Mitsubishi Electric Corporation or an authorized Mitsubishi Semiconductor product distributor for the latest product information before purchasing a product listed herein.

The information described here may contain technical inaccuracies or typographical errors. Mitsubishi Electric Corporation assumes no responsibility for any damage, liability, or other loss rising from these inaccuracies or errors.

Please also pay attention to information published by Mitsubishi Electric Corporation by various means, including the Mitsubishi Semiconductor home page (http://www. MitsubishiElectric.com/).

- •When using any or all of the information contained in these materials, including product data, diagrams, charts, programs, and algorithms, please be sure to evaluate all information as a total system before making a final decision on the applicability of the information and products. Mitsubishi Electric Corporation assumes no responsibility for any damage, liability or other loss resulting from the information contained herein.
- •Mitsubishi Electric Corporation semiconductors are not designed or manufactured for use in a device or system that is used under circumstances in which human life is potentially at stake. Please contact Mitsubishi Electric Corporation or an authorized Mitsubishi Semiconductor product distributor when considering the use of a product contained herein for any specific purposes, such as apparatus or systems for transportation, vehicular, medical, aerospace, nuclear, or undersea repeater use.
- •The prior written approval of Mitsubishi Electric Corporation is necessary to reprint or reproduce in whole or in part these materials.
- •If these products or technologies are subject to the Japanese export control restrictions, they must be exported under a license from the Japanese government and cannot be imported into a country other than the approved destination.
- Any diversion or re-export contrary to the export control laws and regulations of Japan and/or the country of destination is prohibited.
- •Please contact Mitsubishi Electric Corporation or an authorized Mitsubishi Semiconductor product distributor for further details on these materials or the products contained therein.

© 2012 MITSUBISHI ELECTRIC CORPORATION. ALL RIGHTS RESERVED.